

# International coordination

- AIAG: coordination of XML standards – now OASIS (S. Europe mfgs), UNCEFACT – will use SAE to certify s/w products for U.S. auto industry (Jim Tishkowski, DCX)
- European consortium dealing w/non-contact sensors (sensor mfg and CMM vendors) – meet every ~4 wks (Felix Hoben, Otto Boucki, Carl Zeiss)
- I++: overlap w/AP219 and all other projects, may organize through VDA (Gerd Becker, DCX AG)

- ISO TC184/SC1 (DMIS, STEP-NC) US has not participated in SC1 in last 4-5 yr. US representation on SC1 will be NC people (Neal Laurance)
- European DMIS User Group (Gerd Becker)
- International Association of CMM/metrology suppliers (new) supporting intl stds in metrology (training, software, service qualification, user interfaces) I++ provides input, IA.CMM responds – legal consortium, members (Felix Hoben)

- Canadian metrology association (should be invited) (Bob Waite)
- Japan?? Korea, China - Mitutoyo and Zeiss (Plonka: Mazda, Steve Scigliano will check out)

# Questions

- Should there be a separate ISO TC184 Metrology Subcommittee? How to influence international standards?
- Is the Consortium international?  
A: North America with international ties and coordination.

# **Actions**

- Get contacts
- Make them aware of this activity
- Invite participation in meetings
- Address issue of US participation in ISO TC184

# **Participants**

Clay Tornquist

Gerd Becker

Steve Scigliano

Jim Tishkowski

Neal Laurance

Felix Hoben

Al Wavering